

Features

- High-speed access times
Com'l: 7, 8, 10, 12, and 15 ns
Ind'l: 8, 10, 12, and 15 ns
- Low power operation (typical)
 - PDM41256SA
Active: 400 mW
Standby: 150 mW
 - PDM41256LA
Active: 350 mW
Standby: 25 mW
- Single +5V ($\pm 10\%$) power supply
- TTL-compatible inputs and outputs
- Packages
 - Plastic SOJ (300 mil) - TSO
 - Plastic TSOP - T

Description

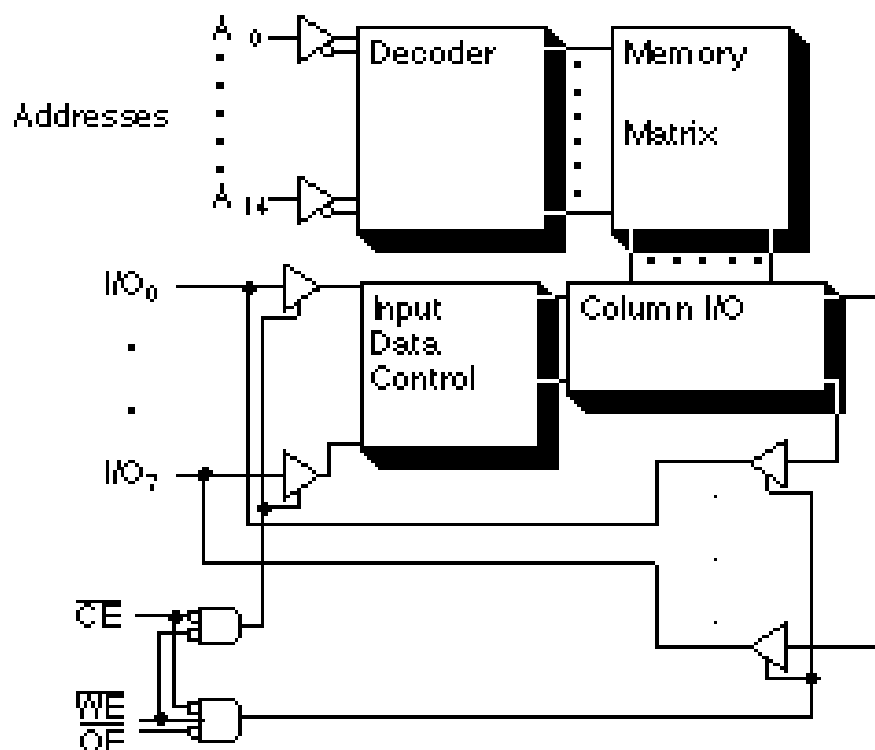
The PDM41256 is a high-performance CMOS static RAM organized as 32,768 x 8 bits. This product is produced in Paradigm's proprietary CMOS technology which offers the designer the highest speed parts. Writing to this device is accomplished when the write enable ($\overline{WE}$) and the chip enable ($\overline{CE}$) inputs are both LOW. Reading is accomplished when $\overline{WE}$ remains HIGH and $\overline{CE}$ and $\overline{OE}$ are both LOW.

The PDM41256 operates from a single +5V power supply and all the inputs and outputs are fully TTL-compatible. The PDM41256 comes in two versions, the standard power version PDM41256SA and a low power version the PDM41256LA. The two versions are functionally the same and only differ in their power consumption.

The PDM41256 is available in a 28-pin plastic TSOP and a 28-pin 300-mil plastic SOJ.

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Functional Block Diagram

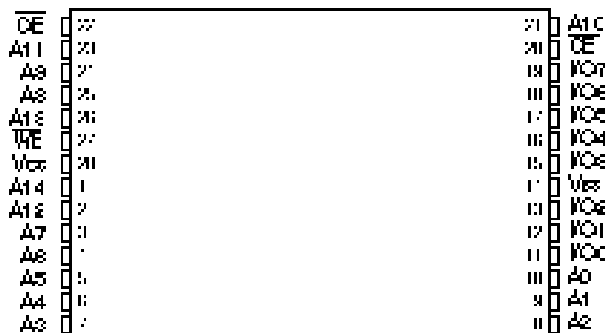


Pin Configurations

SOJ

Pin Description

TSOP



Name	Description
A14-A0	Address Inputs
I/O7-I/O0	Data Inputs/Outputs
OE	Output Enable Input
WE	Write Enable Input
CE	Chip Enable Input
V _{CC}	Power (+5V)
V _{SS}	Ground

Truth Table

OE	WE	CE	I/O	MODE
X	X	H	Hi-Z	Standby
L	H	L	D _{OUT}	Read
X	L	L	D _{IN}	Write
H	H	L	Hi-Z	Output Disable

NOTE: 1. H = V_{IH}, L = V_{IL}, X = DON'T CARE

Absolute Maximum Ratings ⁽¹⁾

Symbol	Rating	Com'l.	Ind.	Unit
V _{TERM}	Terminal Voltage with Respect to V _{SS}	-0.5 to +7.0	-0.5 to +7.0	V
T _{BIAS}	Temperature Under Bias	-55 to +125	-65 to +135	°C
T _{STG}	Storage Temperature	-55 to +125	-65 to +150	°C
P _T	Power Dissipation	1.0	1.0	W
I _{OUT}	DC Output Current	50	50	mA

NOTE: 1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Recommended DC Operating Conditions

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{CC}	Supply Voltage	4.5	5.0	5.5	V
V _{SS}	Supply Voltage	0	0	0	V
Commercial	Ambient Temperature	0	25	70	°C
Industrial	Ambient Temperature	-40	25	85	°C

DC Electrical Characteristics ($V_{CC} = 5.0V \pm 10\%$)

Symbol	Parameter	Test Conditions		PSM41256SA		PSM41256LA		Unit
				Min.	Max.	Min.	Max.	
I_{LI}	Input Leakage Current	$V_{CC} = MAX., V_{IN} = V_{SS} \text{ to } V_{CC}$	Com'l/ Ind.	-5	5	-5	5	μA
I_{LO}	Output Leakage Current	$V_{CC} = MAX.,$ $\overline{CE} = V_{IH}, V_{OUT} = V_{SS} \text{ to } V_{CC}$	Com'l/ Ind.	-5	5	-5	5	μA
V_{IL}	Input Low Voltage			-0.5 ⁽¹⁾	0.8	-0.5 ⁽¹⁾	0.8	V
V_{IH}	Input High Voltage			2.2	6.0	2.2	6.0	V
V_{OL}	Output Low Voltage	$I_{OL} = 8 \text{ mA}, V_{CC} = \text{Min.}$ $I_{OL} = 10 \text{ mA}, V_{CC} = \text{Min.}$		—	0.4 0.5	—	0.4 0.5	V
V_{OH}	Output High Voltage	$I_{OH} = -4 \text{ mA}, V_{CC} = \text{Min.}$		2.4	—	2.4	—	V

NOTE: 1. $V_{IL}(\text{min}) = -3.0V$ for pulse width less than 20 ns.

Power Supply Characteristics

Symbol	Parameter	Power	-7	-8		-10		-12		-15		Units
			Com'l.	Com'l.	Ind.	Com'l.	Ind.	Com'l.	Ind.	Com'l.	Ind.	
I_{CC}	Operating Current $\overline{CE} = V_{IL}$ $f = f_{MAX} = 1/t_{RC}$ $V_{CC} = \text{Max}$ $I_{OUT} = 0 \text{ mA}$	SA	210	200	210	190	200	180	190	170	180	mA
		LA	190	180	190	170	180	160	170	150	160	mA
I_{SB}	Standby Current $\overline{CE} = V_{IH}$ $f = f_{MAX} = 1/t_{RC}$ $V_{CC} = \text{Max}$	SA	90	80	80	70	70	60	60	50	50	mA
		LA	90	80	80	70	70	60	60	50	50	mA
I_{SB1}	Full Standby Current $\overline{CE} \geq V_{CC} - 0.2V$ $f = 0$ $V_{CC} = \text{Max}$ $V_{IN} \geq V_{CC} - 0.2V \text{ or } \leq 0.2V$	SA	20	20	20	20	20	20	20	20	20	mA
		LA	5	5	10	5	10	5	10	5	10	mA

SHADED AREA = PRELIMINARY DATA

NOTE: All values are maximum guaranteed values.

Capacitance⁽¹⁾ ($T_A = +25^\circ C, f = 1.0 \text{ MHz}$)

Symbol	Parameter	Max.	Unit
C_{IN}	Input Capacitance	8	pF
C_{OUT}	Output Capacitance	8	pF

NOTE: 1. This parameter is determined by device characterization but is not production tested.

AC Test Conditions

Input pulse levels	V_{SS} to 3.0V
Input rise and fall times	3 ns
Input timing reference levels	1.5V
Output reference levels	1.5V
Output load	See Figures 1 and 2

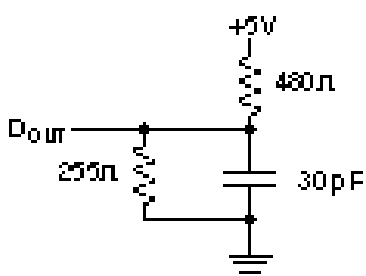


Figure 1. Output Load Equivalent

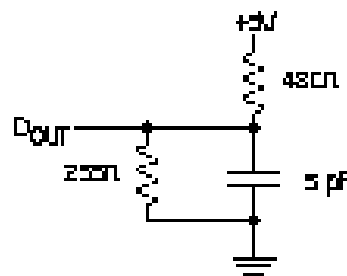


Figure 2. Output Load Equivalent
(for t_{LZCE} , t_{HZCE} , t_{LZWE} , t_{HZWE} , t_{LZOE} , t_{HZOE})

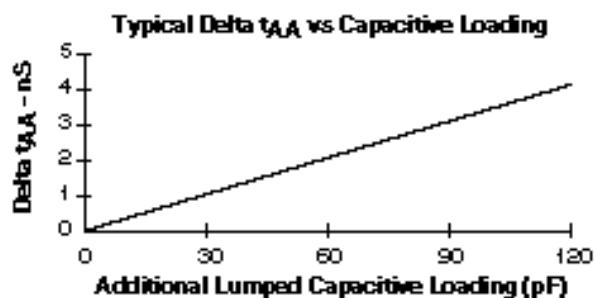
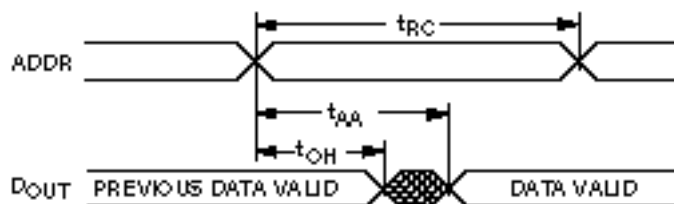
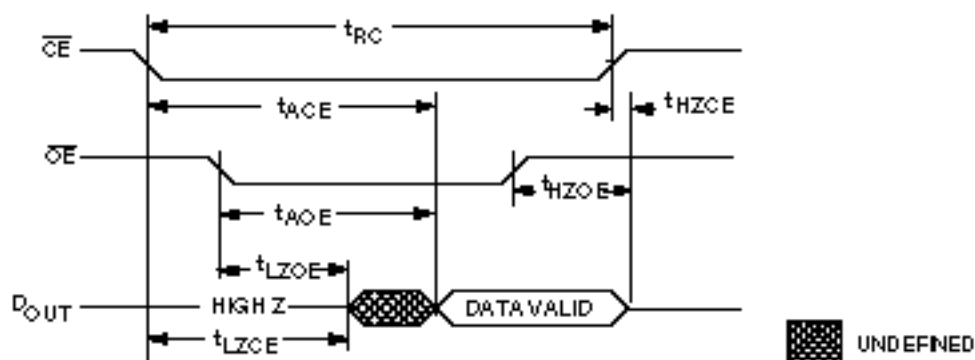


Figure 3.

Read Cycle No. 1⁽¹⁾



Read Cycle No. 2⁽²⁾



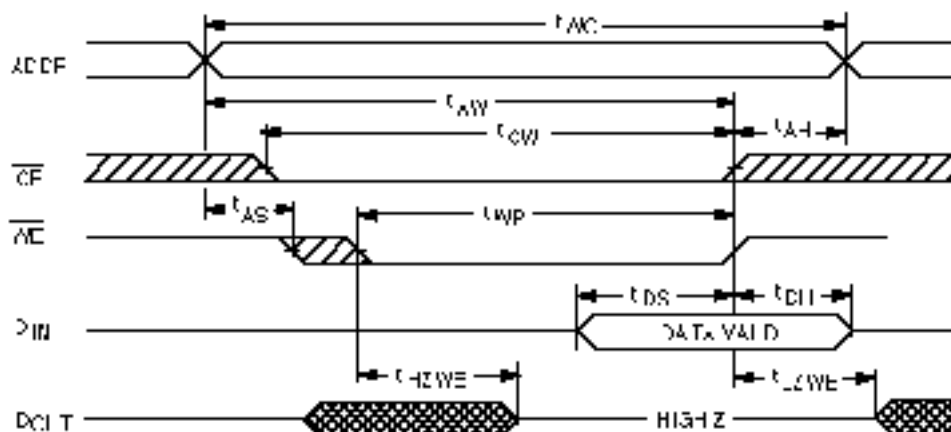
AC Electrical Characteristics

Description		-7 ⁽⁶⁾		-8 ⁽⁶⁾		-10 ⁽⁶⁾		-12		-15		
READ Cycle	Sym	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
READ cycle time	t _{RC}	7		8		10		12		15		ns
Address access time	t _{AA}		7		8		10		12		15	ns
Chip enable access time	t _{ACE}		7		8		10		12		15	ns
Output hold from address change	t _{OH}	3		3		3		3		3		ns
Chip enable to output in low Z ^(3, 4, 5)	t _{LZCE}	5		5		5		5		5		ns
Chip disable to output in high Z ^(3, 4, 5)	t _{HZCE}		5		6		6		6		6	ns
Chip enable to power up time ⁽⁴⁾	t _{PU}	0		0		0		0		0		ns
Chip disable to power down time ⁽⁴⁾	t _{PD}		7		8		10		12		15	ns
Output enable access time	t _{AOE}		5		5		5		6		8	ns
Output enable to output in low Z ^(4, 5)	t _{LZOE}	0		0		0		0		0		ns
Output disable to output in high Z ^(4, 5)	t _{HZOE}		5		6		6		6		6	ns

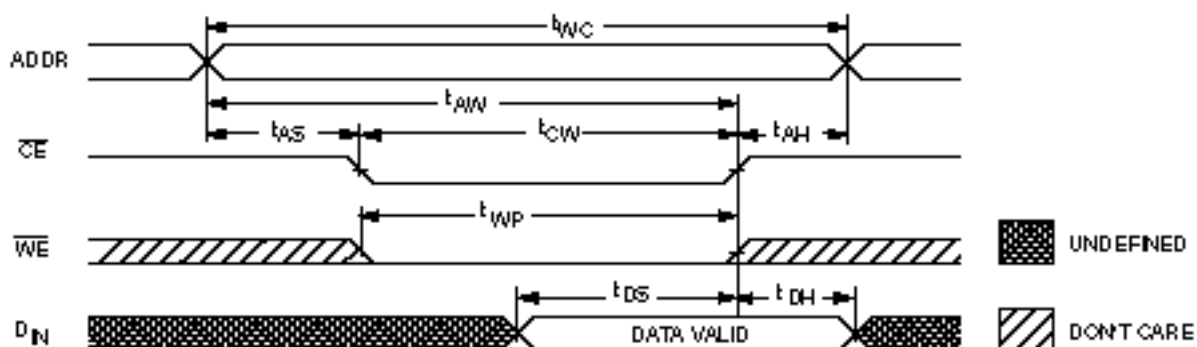
SHADED AREA = PRELIMINARY DATA.

Notes referenced are after Data Retention Table.

Write Cycle No. 1 (Write Enable Controlled)



Write Cycle No. 2 (Chip Enable Controlled)

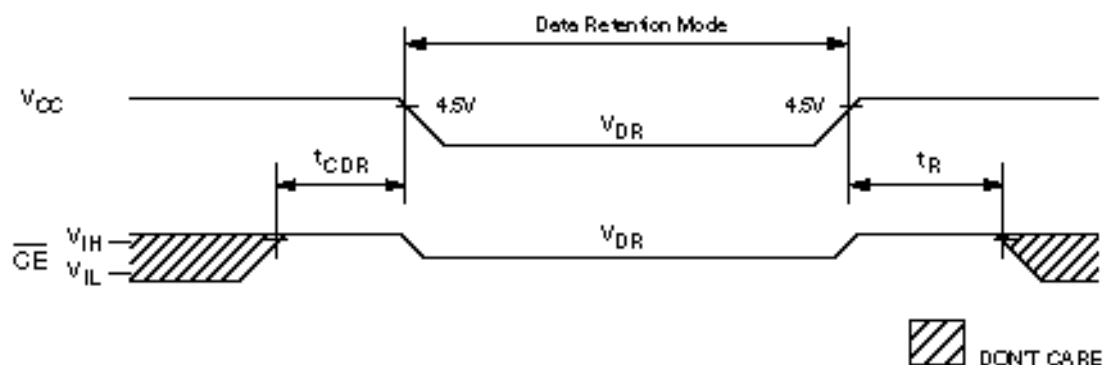


AC Electrical Characteristics

Description		-7 ⁽⁶⁾		-8 ⁽⁶⁾		-10 ⁽⁶⁾		-12		-15		
WRITE Cycle	Sym	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
WRITE cycle time	t _{WC}	7		8		10		12		15		ns
Chip enable to end of write	t _{CW}	7		8		10		10		12		ns
Address valid to end of write	t _{AW}	7		8		10		10		12		ns
Address setup time	t _{AS}	0		0		0		0		0		ns
Address hold from end of write	t _{AH}	0		0		0		0		0		ns
Write pulse width	t _{WP}	7		8		10		10		11		ns
Data setup time	t _{DS}	6		7		7		7		7		ns
Data hold time	t _{DH}	0		0		0		0		0		ns
Write disable to output in low Z ^(4, 5)	t _{LZWE}	0		0		0		0		0		ns
Write enable to output in high Z ^(4, 5)	t _{HZWE}		3		3		3		3		3	ns

SHADED AREA = PRELIMINARY DATA.

Low V_{CC} Data Retention Waveform



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Data Retention Electrical Characteristics (LA Version Only)

Symbol	Parameter	Test Conditions		Min.	Typ.	Max.	Unit
V_{DR}	V_{CC} for Retention Data			2	—	—	V
I_{CCDR}	Data Retention Current	$\overline{CE} \geq V_{CC} - 0.2V$ $V_{IN} \geq V_{CC} - 0.2V$ or $\leq 0.2V$	$V_{CC} = 2V$	—	95	500	μA
			$V_{CC} = 3V$	—	350	750	μA
t_{CDR}	Chip Deselect to Data Retention Time			0	—	—	ns
$t_R^{(4)}$	Operation Recovery Time			t_{RC}	—	—	ns

NOTES: (For three previous Electrical Characteristics tables)

1. The device is continuously selected. Chip Enable is held in its active state.
2. The address is valid prior to or coincident with the latest occurring Chip Enable.
3. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE} .
4. This parameter is sampled.
5. The parameter is tested with $C_L = 5 \text{ pF}$ as shown in Figure 2. Transition is measured $\pm 200 \text{ mV}$ from steady state voltage
6. $V_{CC} = 5V \pm 5\%$.

Ordering Information

PDM	xxxxx Device Type	x Power	xx Speed	x Package Type	x Process Temp. Range	
						Blank Commercial (0° to +70°C)
						I Industrial (−40°C to +85°C)
						TSO 28-pin 300-mil Plastic SOJ
						T 28-pin Plastic TSOP
						7 Commercial Only
						8
						10
						12
						15
						SA Standard Power
						LA Low Power
						41256 256K (32K × 8) Static RAM



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- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

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